PRESS MAIL LABEL NO.: EV485808998US

Form PTO-1449 Applicant:

Takayuki Mizuno, et al.

Serial No.:

10/727,171

Att'y Docket No.: 14321.60

Filing Date:

December 3,2003

Group: 3663

Sheet 1 of 3

Confirmation No.:

5976

For:

OPTICAL MULTI/DEMULTIPLEXING CIRCUIT EQUIPPED WITH

PHASE GENERATING DEVICE

SUPPLEMENTAL INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT

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Examiner <u>Initial*</u>	Patent Number	Publ./Issue Date	<u>Name</u>	Filing <u>Date</u>
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701 A5.	EP1227359	01/25/2002	Europe			no
701 A6.	EP1168010	6/26/2001	Europe			no

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